

# INTERNATIONAL STANDARD

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INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE  
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BASIC EMC PUBLICATION  
PUBLICATION FONDAMENTALE EN CEM

**Specification for radio disturbance and immunity measuring apparatus and methods –**

**Part 2-1: Methods of measurement of disturbances and immunity – Conducted disturbance measurements**

**Spécifications des méthodes et des appareils de mesure des perturbations radioélectriques et de l'immunité aux perturbations radioélectriques –**

**Partie 2-1: Méthodes de mesure des perturbations et de l'immunité – Mesures des perturbations conduites**

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INTERNATIONAL ELECTROTECHNICAL COMMISSION  
INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

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**SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY  
MEASURING APPARATUS AND METHODS –**

**Part 2-1: Methods of measurement of disturbances and immunity –  
Conducted disturbance measurements**

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